Application/Control No. Applicant(s)/Patent Under Reexamination. 09/692,720 SEKIGUCHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2621 Nhon T. Diep **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2002/0009232 01-2002 SODAGAR et al. 382/232 Α В US-4,651,206 03-1987 Ohki, Junichi 375/240.16 С US-6,304,607 10-2001 Talluri et al. 375/240.27 US-D US-Ε US-F US-G US-Н US-1 US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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